

PTO/SB/08b (09-08)

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)			Application Number	10/587,998-Conf. #4347	
			Filing Date	August 1, 2006	
			First Named Inventor	Andreas Eipper	
			Art Unit	1796	
			Examiner Name	Lee, Doris L.	
Sheet	1	of	4	Attorney Docket Number	12810-00333-US1

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